g		TEST and OPERATING PROCEDURE		
	GE Industrial Systems			
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		1	Polet Durll	
TITLE:		PROCEDURE:		
	IC3600SOIA TEST PROCEDURI	LOU-GED- IC3600SQIA-B		

1. <u>INTRODUCTORY DESCRIPTION</u>

- A. This procedure establishes the methods for testing a IC3600SQIA Comparator.
- B. Environmental ranges: 70 +/- 10 Deg. F. with 20-75% R.H.
- C. Unit warm-up/stabilization period requirement: NONE
- D. Personnel using this procedure are expected to have a high degree of confidence and expertise in related testing and calibration procedures.
- E. Procedures not explained here are considered to be understood as common practice.

2. TEST EQUIPMENT VERIFICATION

- A. Verify the accuracy of the standard(s) used in the repair/calibration process by evidence of recent calibration labeling affixed to the test equipment.
- B. All measurement standards used in this procedure shall be traceable to the NATIONAL INSTITUTE of STANDARDS and TECHNOLOGY (N.I.S.T.) and shall have the accuracy, stability, range and resolution required for the intended use.
- C. Unless otherwise specified, the collective uncertainty of the Measurement Standard(s) shall not exceed twenty five percent of the acceptable tolerance for each characteristic being calibrated.
- D. All deviations shall be documented.

3. EQUIPMENT CLEANING

A. All equipment cleaning will be performed as instructed in the GEES SOP Sec. 14.0

4. EQUIPMENT INSPECTION

- A. The following criteria should be used as a guideline or basis for the inspection process of the this unit:
 - 1. Wires broken or cracked.
 - 2. Terminal strips / connectors broken or cracked.
 - 3. Loose wires.
 - 4. Components visually damaged.
 - 5. Capacitors leaking.
 - 6. Solder joint, cold.
 - 7. Circuit board discolored or burned.
 - 8. Printed wire runs burned or damaged.

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5. <u>REVISION HISTORY</u>

Revision	Date	Initials	Reason for Revision
A	10/4/94	PDK	Initial Procedure – After Verification
В	06/07/02	RKD	Added section 5 & 6, Changed procedure number
C			
D			
E			
\mathbf{F}			
G			
H			
I			
J			
K			

g	GE Industrial Systems	TEST and OPERATING PROCEDURE		
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6.	REFERENCE DOCUMENT • Reference: GEK	<u>ATION</u>		
	• Factory Procedure #			
7.	THEORY OF OPERATION A. Refer to the IC3600S0		n Bulletin(s) for theory of operation.	
8.	 TEST EQUIPMENT TO BE General Purpose Testin General Purpose Testin 	g Computer with data a	equisition cards.	
9.	FINAL TEST AND OPERAT	FION PROCESS		

- Assure that the GPTC and GPTI are connected and operational.
- Power up the computer and select board testing programs from the menu.
- Follow the instructions on the screen for testing of the card.

10. SPECIAL INFORMATION

TEST WRITTEN BY: Paul Kelley	DATE:	10/4/94	
TEST VERIFIED BY:		DATE:	